

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/700,157	THOMPSON ET AL.	
Examiner	Art Unit	
Shun Lee	2884	

SEARCHED				
Class	Subclass	Date	Examiner	
250	252.1	11/22/2005	SL	
250	363.03	11/22/2005	SL	
Above	UPDATED	5/16/2006	SL	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, IBM_TDB) - See Search History Printout	5/16/2006	SL
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